

<b>Notice of References Cited</b>	Application/Control No. 10/823,089	Applicant(s)/Patent Under Reexamination VARNER ET AL.	
	Examiner Benjamin Huh	Art Unit 3767	Page 1 of 1

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*	B	US-4,014,334	03-1977	Theeuwes et al.	424/427
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**NON-PATENT DOCUMENTS**

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